

<b>Notice of References Cited</b>	Application/Control No. 10/617,431	Applicant(s)/Patent Under Reexamination ZHANG ET AL.	
	Examiner Robert Shiao	Art Unit 1626	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,600,074	07-2003	Onishi et al.	564/442
	B	US-6,749,756	06-2004	Curran et al.	210/668
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Schwinn et al., 2002, Helvetica Chimica Acta, 85(1): 255-264.
	V	Schwinn et al., 2002, CAS: 137:32933.
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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